

BQ7716xy 具有外部延迟电容器且适用于 2 节至 4 节串联锂离子电池的过压保护器

1 特性

- 2、3 和 4 节串联电池过压保护
- 外部电容器编程的延迟计时器
- 固定的 OVP 阈值
- 高精度过压保护： $\pm 10\text{mV}$
- 低功耗 $I_{CC} \approx 1\mu\text{A}$
($V_{\text{CELL(ALL)}} < V_{\text{PROTECT}}$)
- 每个电池输入的低泄漏电流 $< 100\text{nA}$
- 小型封装引脚尺寸
 - 8 引脚 WSON (3.00 mm × 4.00 mm)

2 应用

- 电动工具
- UPS 备用电池
- 轻型电动车辆
 - 电动自行车 (eBike)
 - 电动踏板车 (eScooter)
 - 踏板辅助自行车

3 说明

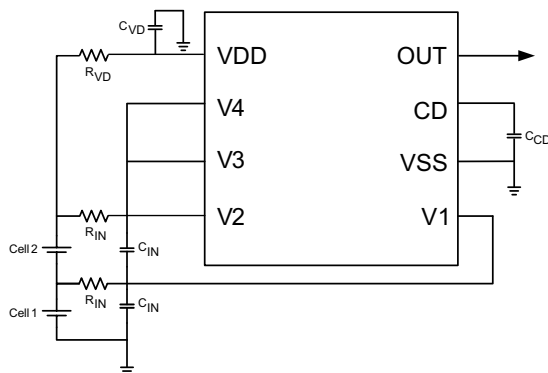
BQ7716xy 器件系列提供了适用于锂离子电池包系统的过压监控器和保护器。独立监控每节电池是否具有过压状态。为了实现更快速的产品线测试，BQ7716xy 器件提供了延迟时间大幅减少的客户测试模式。

在 BQ7716xy 器件中，当检测到任意电池上存在过压状态时，即会启动外部延迟计时器。在延迟定时器超时，输出被触发进入其激活状态（根据配置的不同为高电平或低电平）。外部延迟定时器的特性还包括检测 CD 引脚上开路或者短路延迟电容器（这也将过压条件下触发输出驱动器）的功能。

表 3-1. 器件信息表⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
BQ771600	WSON (8)	4.00mm × 3.00mm

(1) 如需了解所有可用封装，请参阅可订购产品附录（在数据表末尾）和 [器件比较表](#)。



简化原理图



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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision D (July 2015) to Revision E (April 2021)	Page
• Removed Product Preview devices.....	3
• Removed Product Preview devices.....	5
Changes from Revision C (August 2014) to Revision D (July 2015)	Page
• 将 QFN 更改为 WSON.....	1
• 新增了 ESD 等级表、特性说明部分、器件功能模式、应用和实现部分、电源相关建议部分、布局部分、器件和文档支持部分以及机械、封装和可订购信息部分.....	1
• Changed the BQ771605 to Production Data.....	3
• Added table note 2, which was hidden inadvertently.....	4
• Moved <i>Pin Details</i> to <i>Feature Description</i> section	8
• Moved from <i>Application Information</i> section to <i>Design Requirements</i> section	13

5 Device Comparison Table

PART NUMBER	OVP (V)	OV HYSTERESIS (V)	OUTPUT DRIVE	TAPE AND REEL (LARGE)	TAPE AND REEL (SMALL)
BQ771600	4.3	0.3	CMOS Active High	BQ771600DPJR	BQ771600DPJT
BQ771601	4.225	0.05	CMOS Active High	BQ771601DPJR	BQ771601DPJT
BQ771602	4.225	0.05	NCH Active Low, Open Drain	BQ771602DPJR	BQ771602DPJT
BQ771604	4.2	0.05	CMOS Active High	BQ771604DPJR	BQ771604DPJT
BQ771605	3.85	0.25	NCH Active Low	BQ771605DPJR	BQ771605DPJT
BQ771611	4.35	0.3	CMOS Active High	BQ771611DPJR	BQ771611DPJT
BQ771612	3.9	0.3	CMOS Active High	BQ771612DPJR	BQ771612DPJT
BQ7716xy future options ⁽¹⁾	3.85 – 4.65	0 – 0.3	CMOS Active High or NCH Active Low, Open Drain	BQ7716xyTBD	BQ7716xyTBD

(1) Contact TI.

6 Pin Configuration and Functions

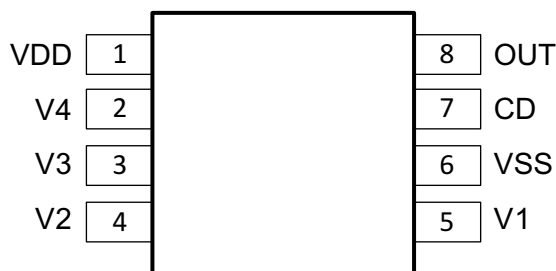


图 6-1. DPJ Package 8-Pin WSON Top View

表 6-1. Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.	I/O ⁽¹⁾	
CD	7	I/O	External capacitor connection for delay timer
OUT	8	OA	Output drive for overvoltage fault signal
VDD	1	P	Power supply
VSS	6	P	Electrically connected to IC ground and negative terminal of the lowest cell in the stack
V1	5	I	Sense input for positive voltage of the lowest cell in the stack
V2	4	I	Sense input for positive voltage of the second cell from the bottom of the stack
V3	3	I	Sense input for positive voltage of the third cell from the bottom of the stack
V4	2	I	Sense input for positive voltage of the fourth cell from the bottom of the stack

(1) IA = Input Analog, OA = Output Analog, P = Power Connection

7 Specifications

7.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Supply voltage range ⁽²⁾	VDD – VSS	– 0.3	30	V
Input voltage range ⁽²⁾	V4 – V3, V3 – V2, V2 – V1, V1 – VSS, or CD – VSS	– 0.3	30	V
Output voltage range ⁽²⁾	OUT – VSS	– 0.3	30	V
Continuous total power dissipation, P _{TOT}		See package dissipation rating.		
Functional temperature		– 40	110	°C
Lead temperature (soldering, 10 s), T _{SOLDER}		300		°C
Storage temperature, T _{stg}		– 65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Absolute maximum ratings for input voltage range, output voltage range, and supply voltage are assured by design and not tested in production.

7.2 ESD Ratings

		VALUE	UNIT
V _{ESD} Rating	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _{DD} ⁽¹⁾	Supply voltage	3		20	V
V4 – V3, V3 – V2, V2 – V1, V1 – VSS, or CD – VSS	Input voltage range	0		5	V
T _A	Operating ambient temperature range	– 40		110	°C

- (1) See § 9.2.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		BQ7716xy	UNIT
		DPJ (WSON)	
		8 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	56.6	°C/W
R _{θJC(top)}	Junction-to-case(top) thermal resistance	56.4	°C/W
R _{θJB}	Junction-to-board thermal resistance	30.6	°C/W
ψ _{JT}	Junction-to-top characterization parameter	1.0	°C/W
ψ _{JB}	Junction-to-board characterization parameter	37.8	°C/W
R _{θJC(bot)}	Junction-to-case(bottom) thermal resistance	11.3	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

7.5 Electrical Characteristics

Typical values stated where $T_A = 25^\circ\text{C}$ and $V_{DD} = 14.4\text{V}$, MIN/MAX values stated where $T_A = -40^\circ\text{C}$ to $+110^\circ\text{C}$ and $V_{DD} = 3\text{V}$ to 20V (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTAGE PROTECTION THRESHOLD VCx					
V_{OV} $V_{(PROTECT)}$ Overvoltage Detection	BQ771600		4.300		V
	BQ771601		4.225		V
	BQ771602		4.225		V
	BQ771604		4.200		V
	BQ771605		3.850		V
	BQ771611		4.350		V
	BQ771612		3.900		V
V_{HYS} OV Detection Hysteresis	BQ771600	250	300	400	mV
	BQ771601	25	50	75	mV
	BQ771602	25	50	75	mV
	BQ771604	25	50	75	mV
	BQ771605	200	250	300	mV
	BQ771611	250	300	400	mV
	BQ771612	250	300	400	mV
V_{OA} OV Detection Accuracy	$T_A = 25^\circ\text{C}$	- 10		10	mV
$V_{OADRIFT}$ OV Detection Accuracy Across Temperature	$T_A = -40^\circ\text{C}$	- 40		44	mV
	$T_A = 0^\circ\text{C}$	- 20		20	mV
	$T_A = 60^\circ\text{C}$	- 24		24	mV
	$T_A = 110^\circ\text{C}$	- 54		54	mV
SUPPLY AND LEAKAGE CURRENT					
I_{CC} Supply Current	$(V_4 - V_3) = (V_3 - V_2) = (V_2 - V_1) = (V_1 - V_{SS}) = 4.0\text{V}$ (See Figure 8-3 .)		1	2	μA
I_{IN} Input Current at Vx Pins	$(V_4 - V_3) = (V_3 - V_2) = (V_2 - V_1) = (V_1 - V_{SS}) = 4.0\text{V}$ (See Figure 8-3 .)	- 0.1		0.1	μA

Typical values stated where $T_A = 25^\circ\text{C}$ and $V_{DD} = 14.4\text{V}$, MIN/MAX values stated where $T_A = -40^\circ\text{C}$ to $+110^\circ\text{C}$ and $V_{DD} = 3\text{V}$ to 20V (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPUT DRIVE OUT, CMOS ACTIVE HIGH VERSIONS ONLY					
V_{OUT1} Output Drive Voltage, Active High	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ or } (V_1 - V_{SS}) > V_{OV}, V_{DD} = 14.4\text{V}, I_{OH} = 100\text{ }\mu\text{A}$	6			V
	If three of four cells are short circuited, only one cell remains powered and $> V_{OV}, V_{DD} = V_x$ (cell voltage), $I_{OH} = 100\text{ }\mu\text{A}$		$V_{DD} - 0.3$		V
	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ and } (V_1 - V_{SS}) < V_{OV}, V_{DD} = 14.4\text{V}, I_{OL} = 100\text{ }\mu\text{A}$ measured into OUT pin		250	400	mV
I_{OUTH1} OUT Source Current (During OV)	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ or } (V_1 - V_{SS}) > V_{OV}, V_{DD} = 14.4\text{V}, \text{ OUT} = 0\text{V}$. Measured out of OUT pin			4.5	mA
I_{OUTL1} OUT Sink Current (No OV)	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ and } (V_1 - V_{SS}) < V_{OV}, V_{DD} = 14.4\text{V}, \text{ OUT} = V_{DD}$. Measured into OUT pin	0.5		14	mA
OUTPUT DRIVE OUT, NCH OPEN DRAIN ACTIVE LOW VERSIONS ONLY					
V_{OUT2} Output Drive Voltage, Active Low	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ or } (V_1 - V_{SS}) > V_{OV}, V_{DD} = 14.4\text{V}, I_{OL} = 100\text{ }\mu\text{A}$ measured into OUT pin		250	400	mV
I_{OUTH2} OUT Sink Current (During OV)	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ or } (V_1 - V_{SS}) > V_{OV}, V_{DD} = 14.4\text{V}, \text{ OUT} = V_{DD}$. Measured into OUT pin	0.5		14	mA
I_{OUTLK} OUT Pin Leakage	$(V_4 - V_3), (V_3 - V_2), (V_2 - V_1), \text{ and } (V_1 - V_{SS}) < V_{OV}, V_{DD} = 14.4\text{V}, \text{ OUT} = V_{DD}$. Measured out of OUT pin			100	nA
DELAY TIMER					
t_{CD} OV Delay Time	$C_{CD} = 0.1\text{ }\mu\text{F}$	1	1.5	2	s
V_{CD} CD Fault Detection External Comparator Threshold, Initial Charge Value	The CD pin will first be quickly charged to this value before being discharged back to VSS.		1.5		V
$t_{CHGDELAY}$ CD Charging Delay	OVP to OUT delay with CD shorted to ground	20		170	ms
I_{CHG} OV Detection Charging Current	CD pin fast charging current from VSS to V_{CD} to begin delay countdown		300		μA
I_{DSG} OV Detection Discharging Current	CD pin discharging current from V_{DELAY} to VSS		100		nA

7.6 Typical Characteristics

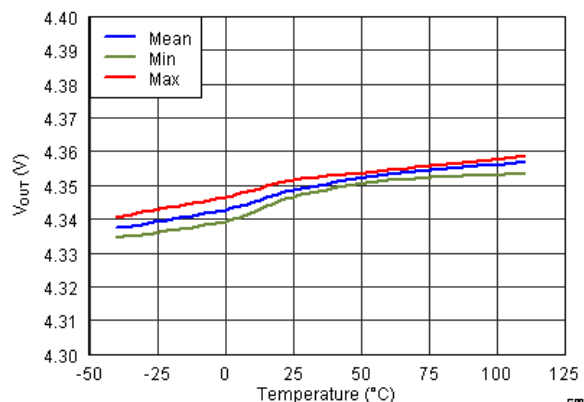


图 7-1. Overvoltage Threshold (OVT) vs. Temperature

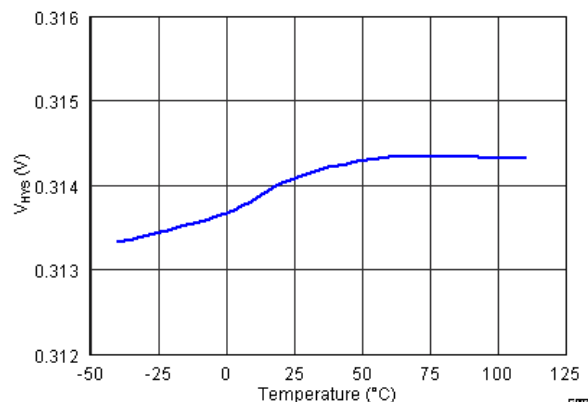


图 7-2. Hysteresis V_{HYS} vs. Temperature

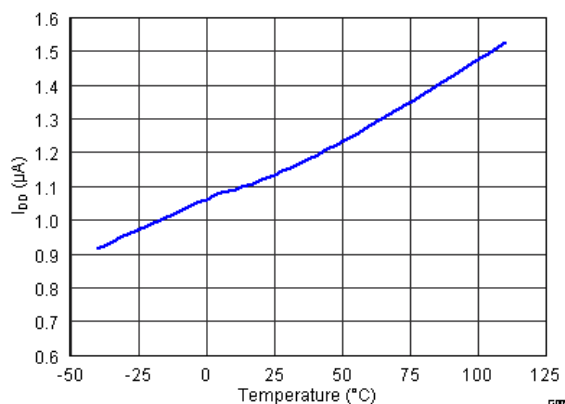


图 7-3. I_{DD} Current Consumption vs. Temperature at $V_{DD} = 16\text{ V}$

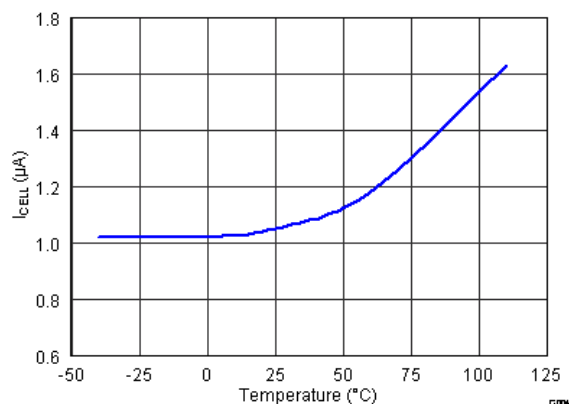


图 7-4. I_{CELL} vs. Temperature at $V_{CELL} = 9.2\text{ V}$

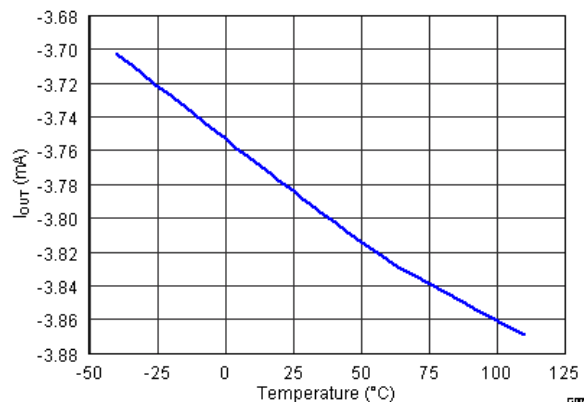


图 7-5. Output Current I_{OUT} vs. Temperature

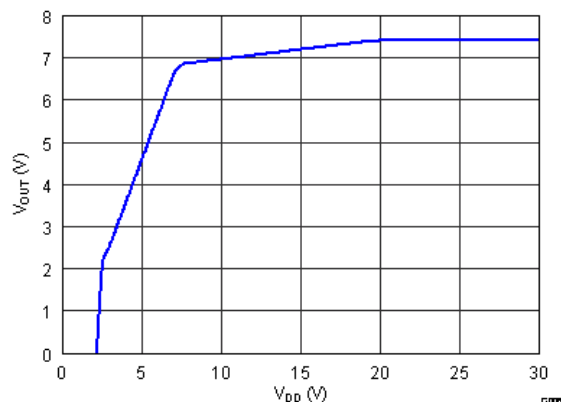


图 7-6. V_{OUT} vs. V_{DD}

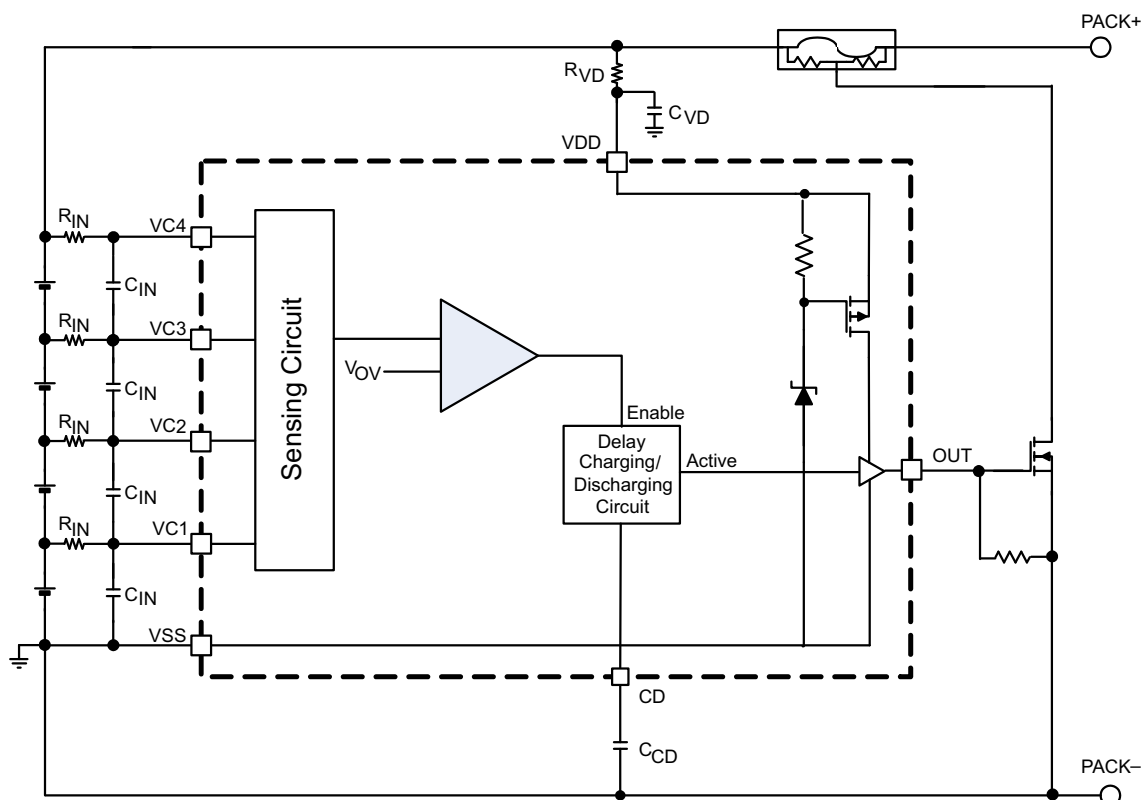
8 Detailed Description

8.1 Overview

In the BQ7716xy family of devices for overvoltage protection, each cell is monitored independently and an external delay timer is initiated if an overvoltage condition is detected when any cell voltage is higher than the protection voltage threshold, V_{OV} . After the delay time expires, the OUT pin is inserted.

For quicker production-line testing, the device provides a Customer Test Mode with greatly reduced delay time.

8.2 Functional Block Diagram



8.3 Feature Description

In the BQ7716xy device, each cell is monitored independently. Overvoltage is detected by comparing the actual cell voltage to a protection voltage reference, V_{OV} . If any cell voltage exceeds the programmed OV value, a timer circuit is activated. This timer circuit charges the CD pin to a nominal value, then slowly discharges it with a fixed current back down to VSS . When the CD pin falls below a nominal threshold near VSS , the OUT terminal goes from inactive to active state. Additionally, a timeout detection circuit checks to ensure that the CD pin successfully begins charging to above VSS and subsequently drops back down to VSS , and if a timeout error is detected in either direction, it will similarly trigger the OUT pin to become active. See [Figure 8-1](#) for reference.

For an NCH Open Drain Active Low configuration, the OUT pin pulls down to VSS when active (OV present), and is high impedance when inactive (no OV).

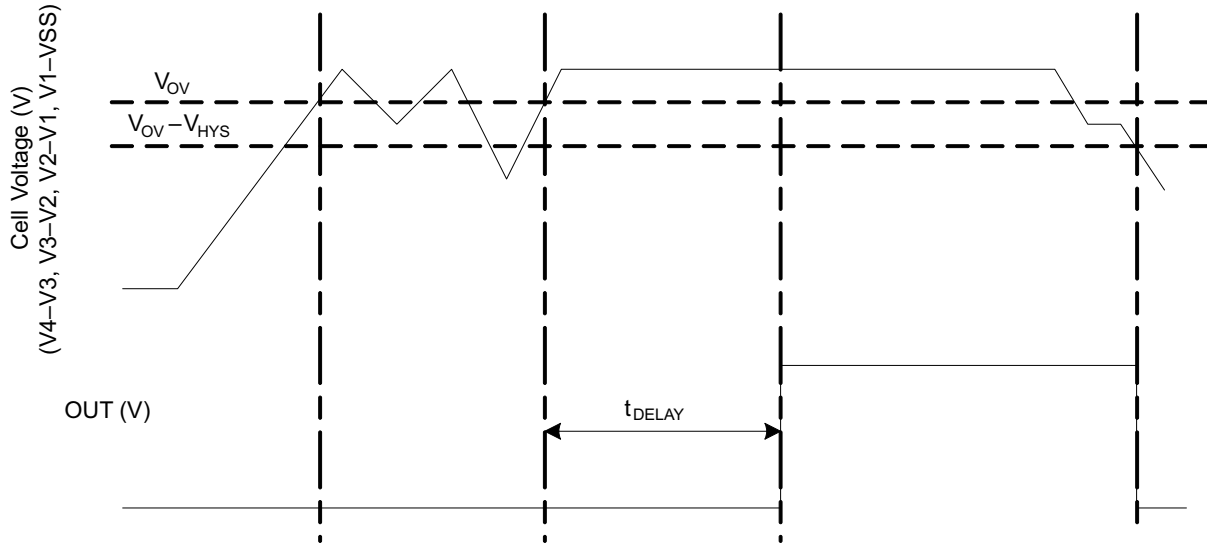


图 8-1. Timing for Overvoltage Sensing

图 8-2 shows an overview of the behavior of the CD pin during an OV sequence.

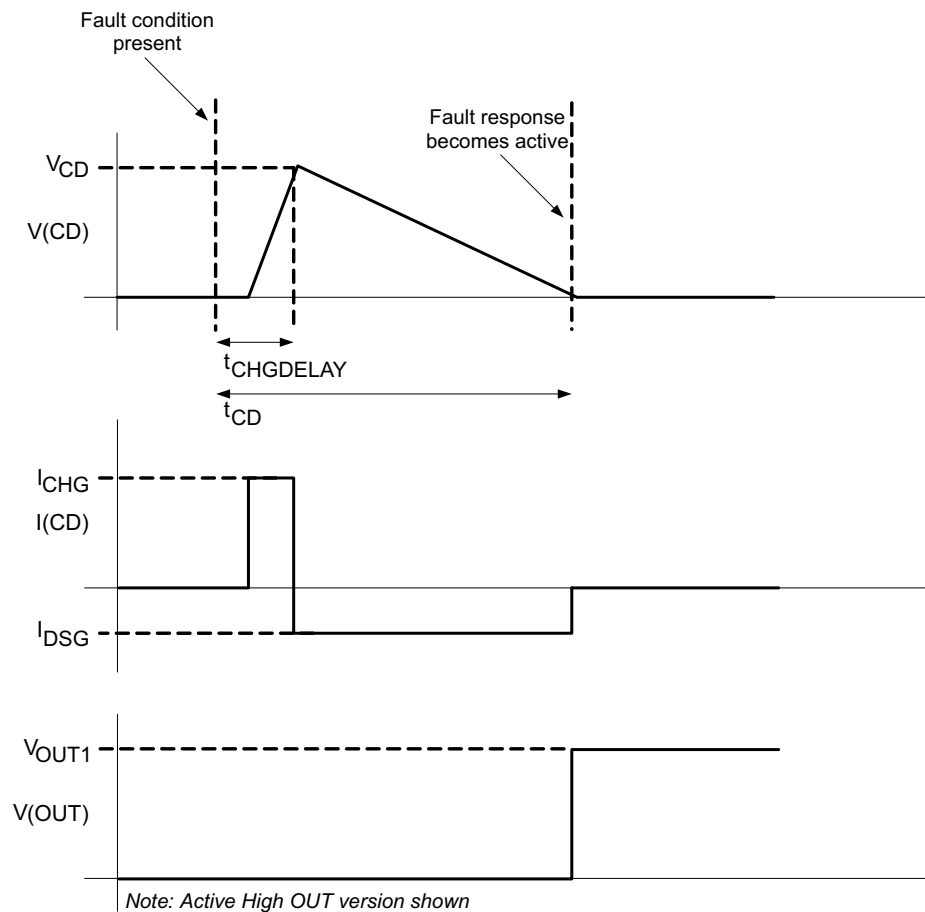


图 8-2. CD Pin Mechanism

8.3.1 Sense Positive Input for Vx

This is an input to sense each single battery cell voltage. A series resistor and a capacitor across the cell for each input is required for noise filtering and stable voltage monitoring.

8.3.2 Output Drive, OUT

This terminal serves as the fault signal output, and may be ordered in either active HIGH or LOW options.

8.3.3 Supply Input, VDD

This terminal is the unregulated input power source for the IC. A series resistor is connected to limit the current, and a capacitor is connected to ground for noise filtering.

8.3.4 External Delay Capacitor, CD

This terminal is connected to an external capacitor that is used for setting the delay timer during an overvoltage fault event.

The CD pin includes a timeout detection circuit to ensure that the output drives active even with a shorted or open capacitor during an overvoltage event.

The capacitor connected on the CD pin rapidly charges to a voltage if any one of the cell inputs exceeds the OV threshold. Then the delay circuit gradually discharges the capacitor on the CD pin. Once this capacitor discharges below a set voltage, the OUT transitions from an inactive to active state.

To calculate the delay, use the following equation:

$$t_{CD} (s) = K \times C_{CD} (\mu F), \text{ where } K = 10 \text{ to } 20 \text{ range.} \quad (1)$$

Example: If $C_{CD} = 0.1 \mu F$ (typical), then the delay timer range is

$$t_{CD} (s) = 10 \times 0.1 = 1 \text{ s (Minimum)}$$

$$t_{CD} (s) = 20 \times 0.1 = 2 \text{ s (Maximum)}$$

备注

The tolerance on the capacitor used for C_{CD} increases the range of the t_{CD} timer.

8.4 Device Functional Modes

8.4.1 NORMAL Mode

When all of the cell voltages are below the overvoltage threshold, VOV, the device operates in NORMAL mode. The device monitors the differential cell voltages connected across (V1 - VSS), (V2 - V1), (V3 - V2), and (V4 - V3). The OUT pin is inactive and if configured:

- Active high is low
- Active low is being externally pulled up and is an open drain

8.4.2 OVERVOLTAGE Mode

OVERVOLTAGE mode is detected if any of the cell voltages exceeds the overvoltage threshold, VOV for configured OV delay time. The OUT pin is activated after a delay time set by the capacitance in the CD pin. The OUT pin will either pull high internally, if configured as active high, or will be pulled low internally, if configured as active low. When all of the cell voltages fall below the (VOV - VHYS), the device returns to NORMAL mode

8.4.3 Customer Test Mode

It is possible to reduce test time for checking the overvoltage function by simply shorting the external CD capacitor to VSS. In this case, the OV delay would be reduced to the $t_{(CHGDELAY)}$ value, which has a maximum of 170 ms.

CAUTION

Avoid exceeding any Absolute Maximum Voltages on any pins when placing the part into Customer Test Mode. Also avoid exceeding Absolute Maximum Voltages for the individual cell voltages ($V_4 - V_3$), ($V_3 - V_2$), ($V_2 - V_1$), and ($V_1 - V_{SS}$). Stressing the pins beyond the rated limits may cause permanent damage to the device.

图 8-3 shows the timing for the Customer Test Mode.

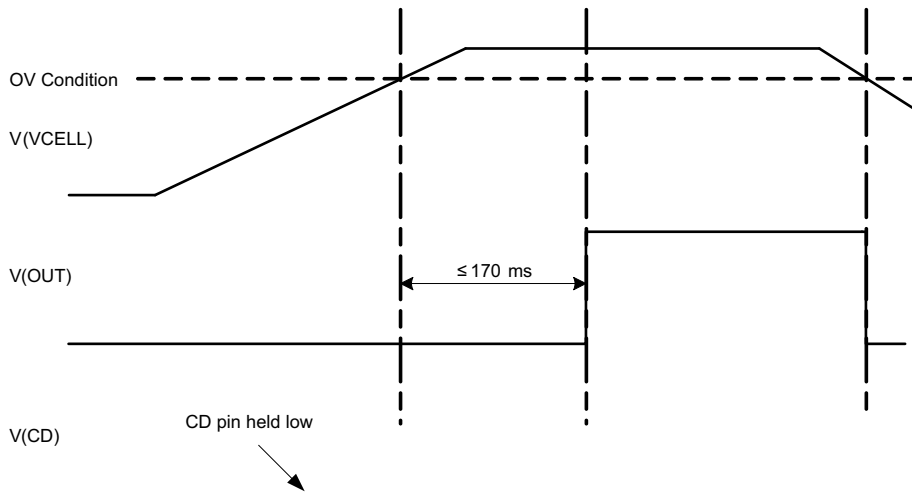


图 8-3. Timing for Customer Test Mode

图 8-4 shows the measurement for current consumption for the product for both V_{DD} and V_x .

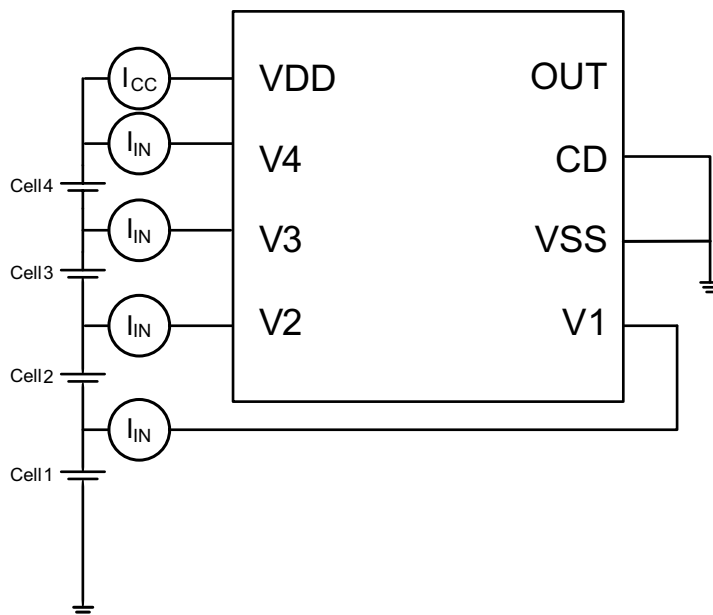


图 8-4. Configuration for IC Current Consumption Test

9 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

9.1 Application Information

图 9-1 shows each external component.

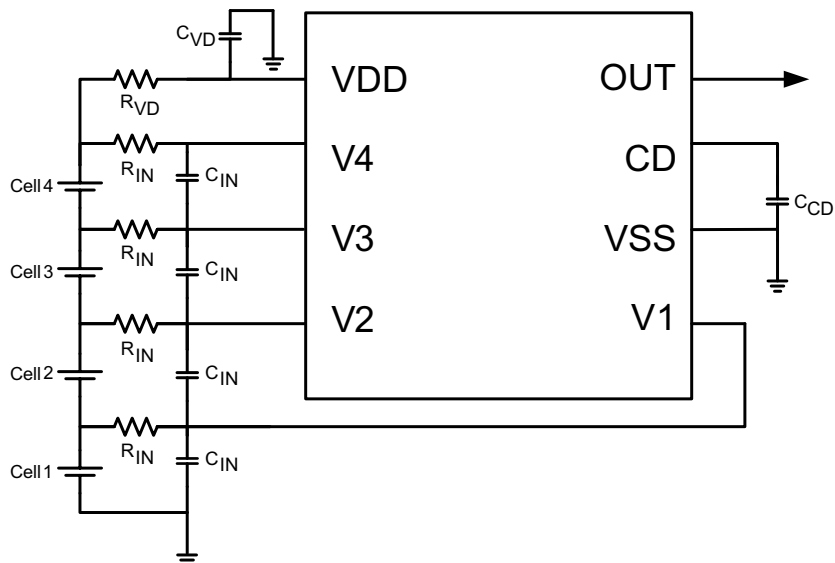


图 9-1. Application Configuration

备注

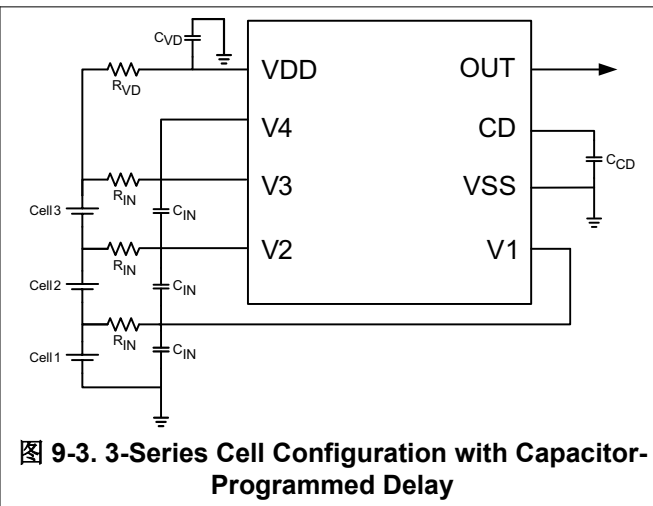
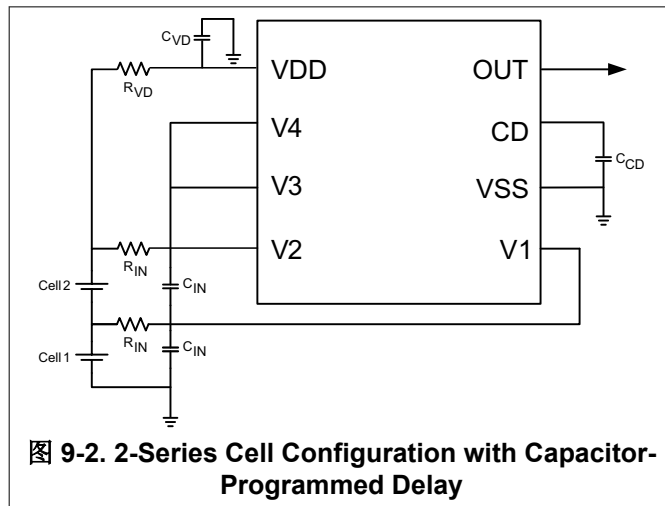
In the case of an Open Drain Active Low configuration, an external pull-up resistor is required on the OUT terminal.

Changes to the ranges stated in 表 9-1 will impact the accuracy of the cell measurements.

备注

The device is calibrated using an R_{IN} value = $1\text{ k}\Omega$. Using a value other than this recommended value changes the accuracy of the cell voltage measurements and V_{OV} trigger level.

9.2 Typical Application



备注

In these application examples of 2 s and 3 s, an external pull-up resistor is required on the OUT terminal to configure for an Open Drain Active Low operation.

9.2.1 Design Requirements

Changes to the ranges stated in 表 9-1 will impact the accuracy of the cell measurements.

表 9-1. Design Parameters

PARAMETER	EXTERNAL COMPONENT	MIN	NOM	MAX	UNIT
Voltage monitor filter resistance	R_{IN}	900	1000	1100	Ω
Voltage monitor filter capacitance	C_{IN}	0.01		0.1	μF
Supply voltage filter resistance	R_{VD}	100		1K	Ω
Supply voltage filter capacitance	C_{VD}		0.1		μF
CD external delay capacitance	C_{CD}		0.1	1	μF
OUT Open drain version pull-up resistance to PACK+	R_{OUT}		100k		Ω

9.2.2 Detailed Design Procedure

- Determine the number of cells in series. The device supports a 2-S to 4-S cell configuration. For 2S and 3S, the top unused pin(s) should be shorted as shown in 图 9-2 and 图 9-3.
- Determine the overvoltage protection delay. Follow the calculation example described in 节 8.3.4. Select the correct capacitor to connect to the CD pin.
- Follow the application schematic to connect the device. If the OUT pin is configured to open drain, an external pull-up resistor should be used. Refer to the Out Sink Current specification, IOUTH2 to ensure a proper pull-up resistor value is used, so that the OUT pin sink current is able to pull down the pin during OV condition.

9.2.3 Application Curves

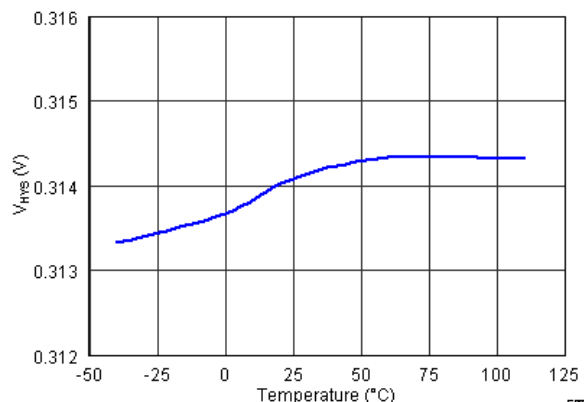


图 9-4. Hysteresis V_{HYS} vs. Temperature

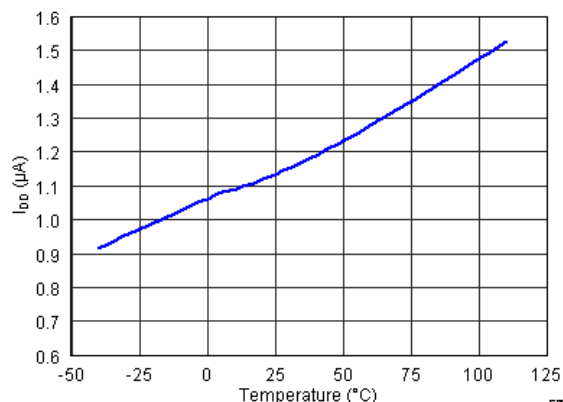


图 9-5. I_{DD} Current Consumption vs. Temperature at $V_{DD} = 16$ V

10 Power Supply Recommendations

The maximum power of this device is 20 W on V_{DD} .

11 Layout

11.1 Layout Guidelines

1. Ensure the RC filters for the V_x pins and V_{DD} pin are placed as close as possible to the target terminal, reducing the tracing loop area.
2. The capacitor for CD pin should be placed close to the IC terminals.

11.2 Layout Example

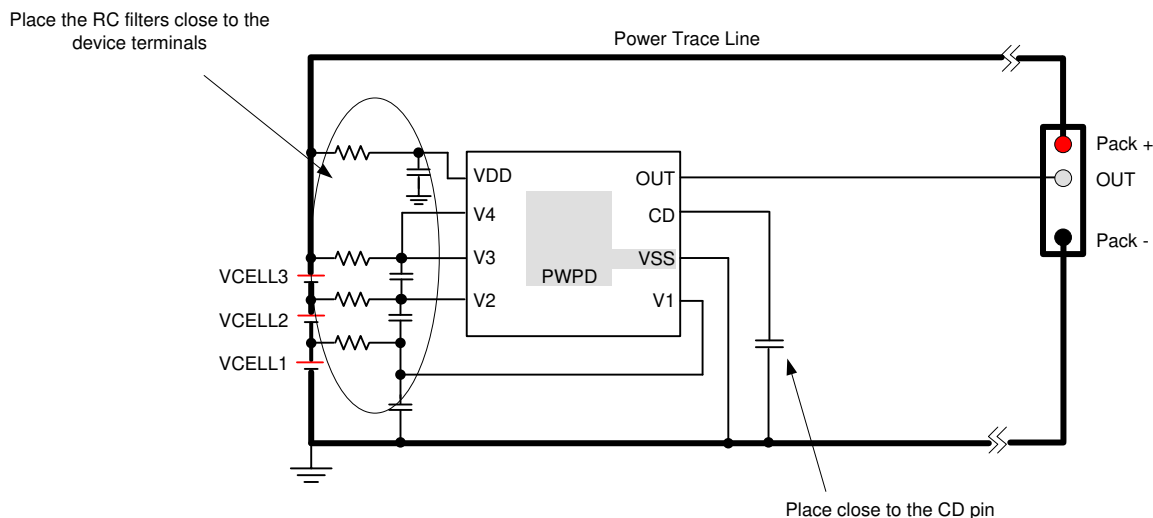


图 11-1. Layout

12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 支持资源

[TI E2E™ 支持论坛](#)是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

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12.6 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
BQ771600DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771600	Samples
BQ771600DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771600	Samples
BQ771601DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771601	Samples
BQ771601DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771601	Samples
BQ771602DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771602	Samples
BQ771602DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		771602	Samples
BQ771604DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771604	Samples
BQ771604DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771604	Samples
BQ771605DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771605	Samples
BQ771605DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771605	Samples
BQ771611DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771611	Samples
BQ771611DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771611	Samples
BQ771612DPJR	ACTIVE	WSON	DPJ	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771612	Samples
BQ771612DPJT	ACTIVE	WSON	DPJ	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	771612	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of ≤ 1000 ppm threshold. Antimony trioxide based flame retardants must also meet the ≤ 1000 ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

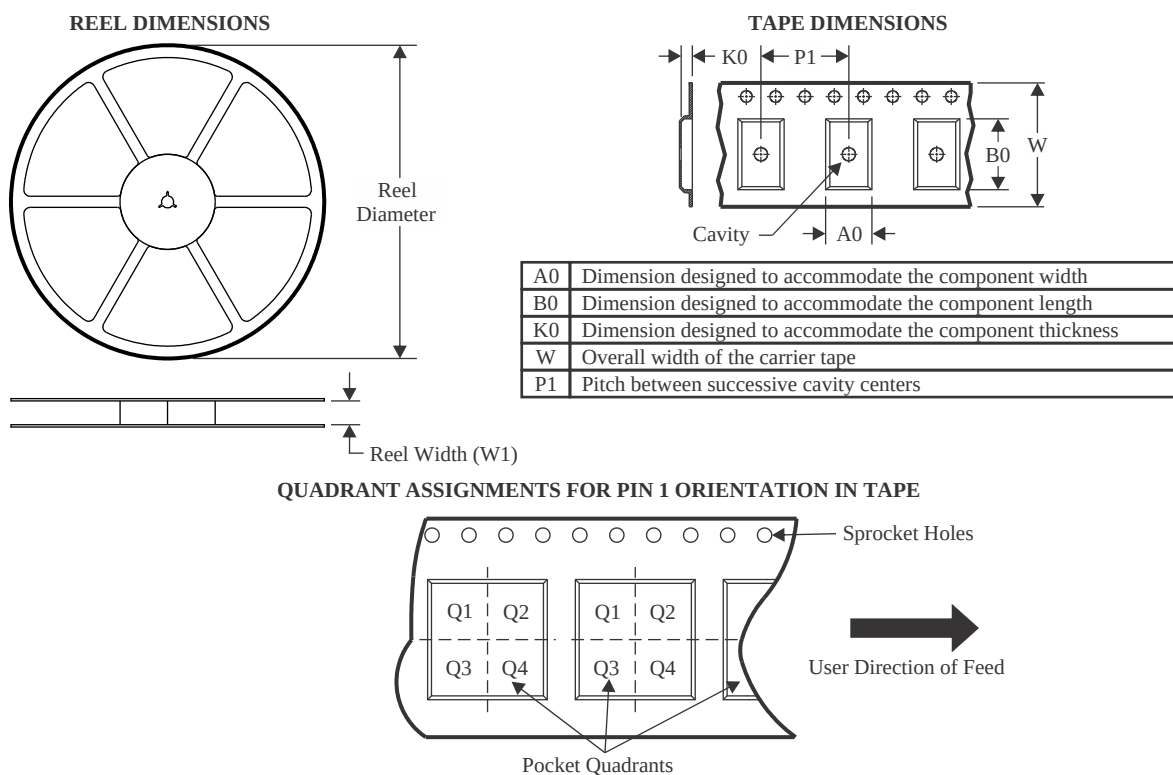
⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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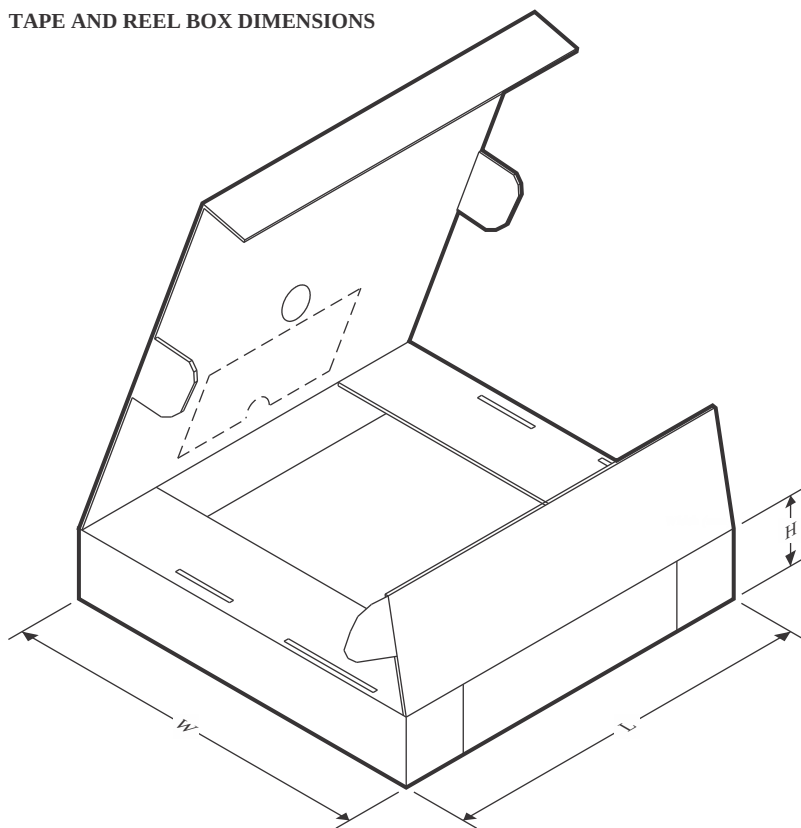
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TAPE AND REEL INFORMATION


*All dimensions are nominal

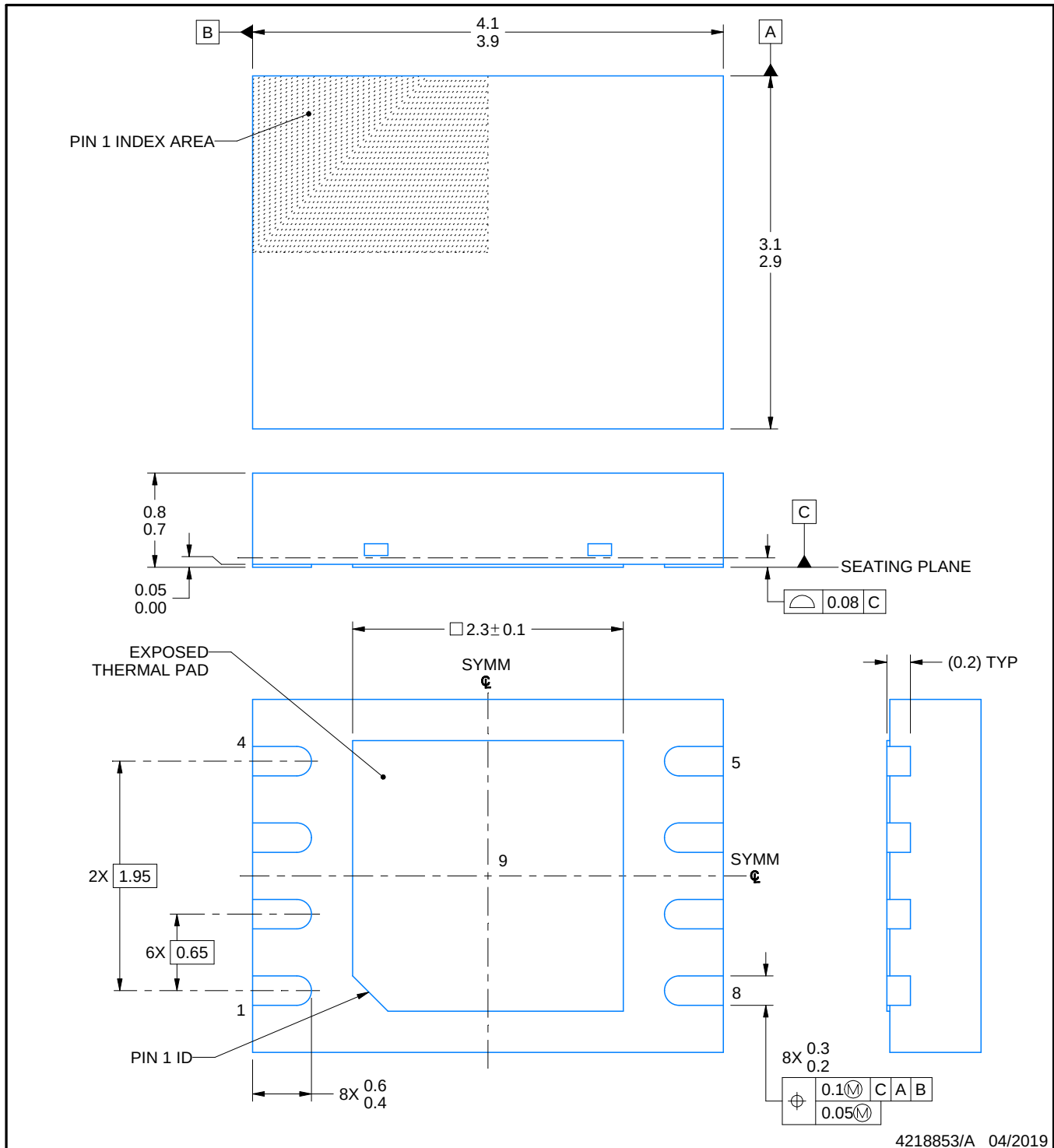
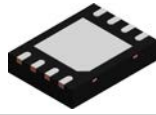
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ771600DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771600DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771601DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771601DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771602DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771602DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771604DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771604DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771605DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771605DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771611DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771611DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771612DPJR	WSO	DPJ	8	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2
BQ771612DPJT	WSO	DPJ	8	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ771600DPJR	WSN	DPJ	8	3000	335.0	335.0	25.0
BQ771600DPJT	WSN	DPJ	8	250	182.0	182.0	20.0
BQ771601DPJR	WSN	DPJ	8	3000	346.0	346.0	33.0
BQ771601DPJT	WSN	DPJ	8	250	210.0	185.0	35.0
BQ771602DPJR	WSN	DPJ	8	3000	335.0	335.0	25.0
BQ771602DPJT	WSN	DPJ	8	250	182.0	182.0	20.0
BQ771604DPJR	WSN	DPJ	8	3000	346.0	346.0	33.0
BQ771604DPJT	WSN	DPJ	8	250	182.0	182.0	20.0
BQ771605DPJR	WSN	DPJ	8	3000	335.0	335.0	25.0
BQ771605DPJT	WSN	DPJ	8	250	182.0	182.0	20.0
BQ771611DPJR	WSN	DPJ	8	3000	335.0	335.0	25.0
BQ771611DPJT	WSN	DPJ	8	250	182.0	182.0	20.0
BQ771612DPJR	WSN	DPJ	8	3000	335.0	335.0	25.0
BQ771612DPJT	WSN	DPJ	8	250	182.0	182.0	20.0



4218853/A 04/2019

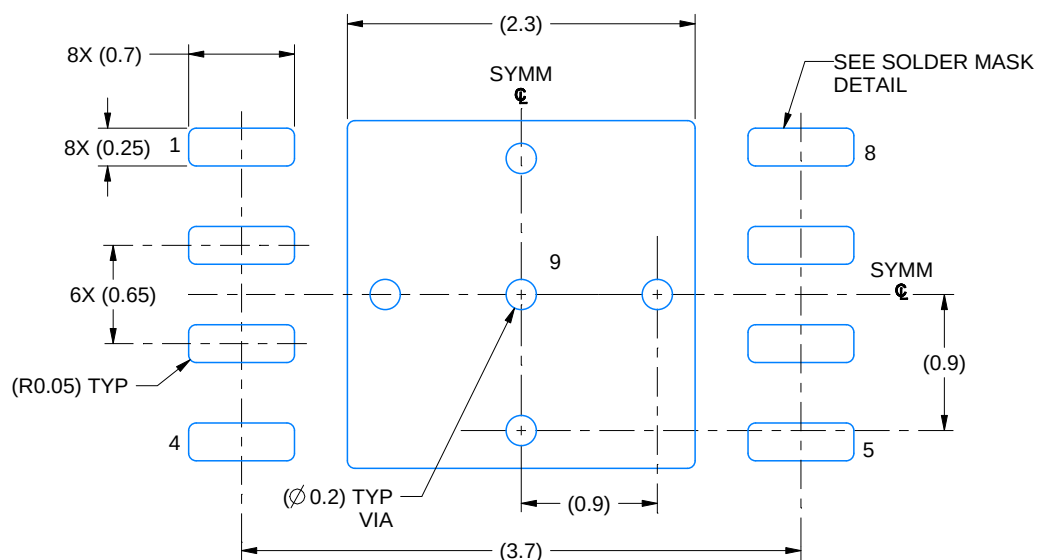
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

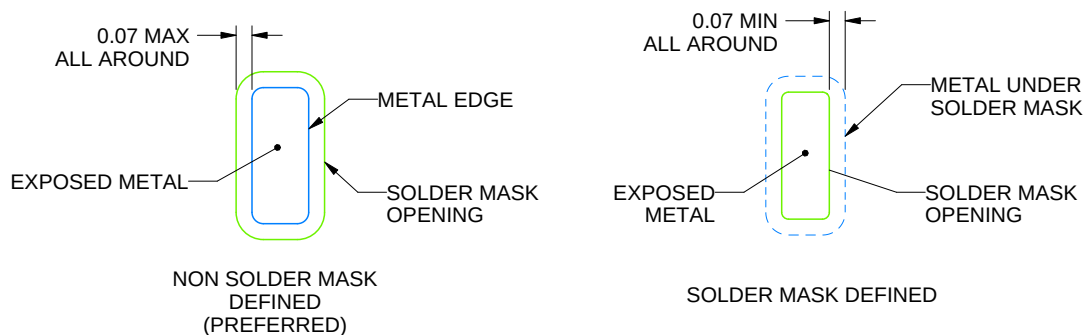
DPJ0008A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X



SOLDER MASK DETAILS

4218853/A 04/2019

NOTES: (continued)

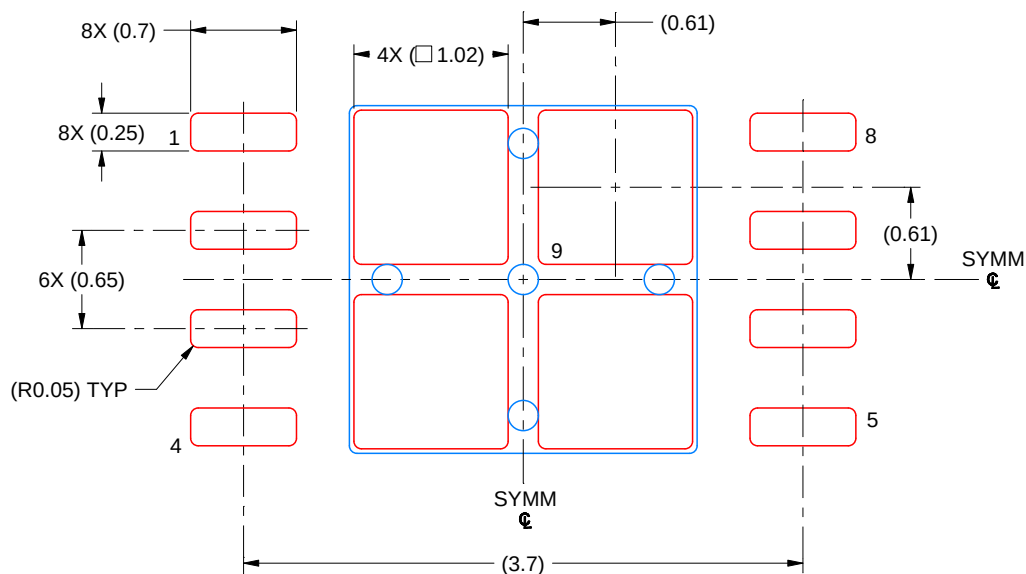
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

DPJ0008A

WSO - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 20X

EXPOSED PAD 9
79% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4218853/A 04/2019

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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